Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexamination KEENEY ET AL.		on
Examiner	Art Unit	<u> </u>
Son M Tang	2632	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,307,328	10-2001	Ko et al.	315/200R
	В	US-5,896,092	04-1999	Bechtel, Jon H.	340/815.73
	С	US-5,595,075	01-1997	Chen, Mike	70/95
	D	US-6,532,406	03-2003	Schmedding et al.	701/29
	Е	US-4,625,151	11-1986	Kataoka, Hiroyuki	315/241P
	F	US-			
	G	US-		·	
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-		·	,

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т				,	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
,	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.